



Report No.: SZ11060021E01

# FCC TEST REPORT

Issued to

Cellon Communications Technology(ShenZhen)Co., Ltd.

For

GPRS mobile phone

Model Name: C5550,PCD252,CL252,TE252PCD252PE,PCD252AL,  
PCD252CL,PCD252EC,PCD252MV,PCD252BOM,PCD252MX,  
PCD252MX,PCD252CR,TE252PE,AL252AL,CL252CL,  
CL252EC,MV252MV,TE252MX,CL252CR,CL252EN,CL252CA  
Brand Name: PCD/Claro  
Trade Name: PCD/Claro  
FCC ID: T38PCD5550  
Standard: 47 CFR Part 15 Subpart B  
Test date: Jul 15, 2011 –Jul 26, 2011  
Issue date: Jul 26, 2011

Shenzhen Morlab Communications Technology Co., Ltd.



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Date 2011.7.26

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Date 2011.7.26

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Date 2011.7.26

CTIA Authorized Test Lab  
LAB CODE 20081223-00  
IEEE 1725

OFTA  
電訊管理局



GCF  
Official Observer of  
Global Certification Forum

Bluetooth  
BQTF

FCC  
Reg. No.  
741109

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| Change History |               |                   |
|----------------|---------------|-------------------|
| Issue          | Date          | Reason for change |
| 1.0            | July 26, 2011 | First edition     |
|                |               |                   |

## 1. GENERAL INFORMATION

### 1.1 EUT Description

EUT Type ..... GPRS mobile phone  
 Serial No..... (n.a, marked #1 by test site)  
 Hardware Version..... p1  
 Software Version ..... C5550\_01.02\_680109\_71021\_SAM\_005  
 Applicant..... Cellon Communications Technology(ShenZhen)Co., Ltd.  
 13/F, Skyworth Building C Gaoxin S. Ave. 1st, High-Tech industrial  
 Park NanShan, ShenZhen  
 Manufacturer..... Cellon Communications Technology(ShenZhen)Co., Ltd.  
 13/F, Skyworth Building C Gaoxin S. Ave. 1st, High-Tech industrial  
 Park NanShan, ShenZhen  
 Modulation Type ..... GSM/GPRS with GMSK Modulation  
 Power Supply ..... Battery  
 Brand Name: PCD  
 Model No.: BTR2096  
 Serial No.: (n.a. marked #1 by test site)  
 Capacitance: 1050 mah  
 Rated Voltage: 3.7V  
 Charge Limit: 4.280V~2.30V  
 Manufacturer: Sunwoda Electronic Co.,LED  
 Ancillary Equipment 1 ..... AC Adapter (Charger for Battery)  
 Brand Name: PCD  
 Model Name: DSA-3RNA-05 FUS 050065  
 Serial No.: (n.a. marked #1 by test site)  
 Rated Input: ~ 100-240V, 50/60Hz, 0.3A  
 Rated Output: = 3.25W  
 Manufacturer: DEE VAN Electronics(ShenZhen) CO., LTD

*Note 1:* The EUT is a GPRS mobile phone; it supports GSM 850MHz, 1900MHz and GPRS module.

*Note 2:* The EUT is equipped with a T-Flash card slot; equipped with a special port which can be connected to the ancillary equipments supplied by the manufacturer e.g. the AC Adapter and the USB Adapter Cable.

*Note 3:* For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

## 1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

| No. | Identity                            | Document Title          |
|-----|-------------------------------------|-------------------------|
| 1   | 47 CFR Part 15<br>(10-1-09 Edition) | Radio Frequency Devices |

Test detailed items/section required by FCC rules and results are as below:

| No. | Section | Description        | Result |
|-----|---------|--------------------|--------|
| 1   | 15.107  | Conducted Emission | PASS   |
| 2   | 15.109  | Radiated Emission  | PASS   |

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.

## 1.3 Facilities and Accreditations

### 1.3.1 Facilities

Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L3572.

All measurement facilities used to collect the measurement data are located at 3/F, Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055 P. R. China. The test site is constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22; the FCC registration number is 741109.

### 1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

|                             |         |
|-----------------------------|---------|
| Temperature (°C):           | 15 - 35 |
| Relative Humidity (%):      | 30 -60  |
| Atmospheric Pressure (kPa): | 86-106  |

### 1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

|                                    |        |
|------------------------------------|--------|
| Uncertainty of Conducted Emission: | ±1.8dB |
| Uncertainty of Radiated Emission:  | ±3.1dB |

## 2. TEST CONDITIONS SETTING

### 2.1 Test Mode

- (1) The first test mode (Idle)

The EUT configuration of the emission tests is EUT + Battery + Charger.

During the test, The EUT was synchronized to the BCCH, listening to the CCCH and able to respond to paging message. Periodic location updating was disabled.

- (2) The second test mode (USB)

The EUT configuration of the emission tests is TransFlash Card + EUT + Battery + PC.

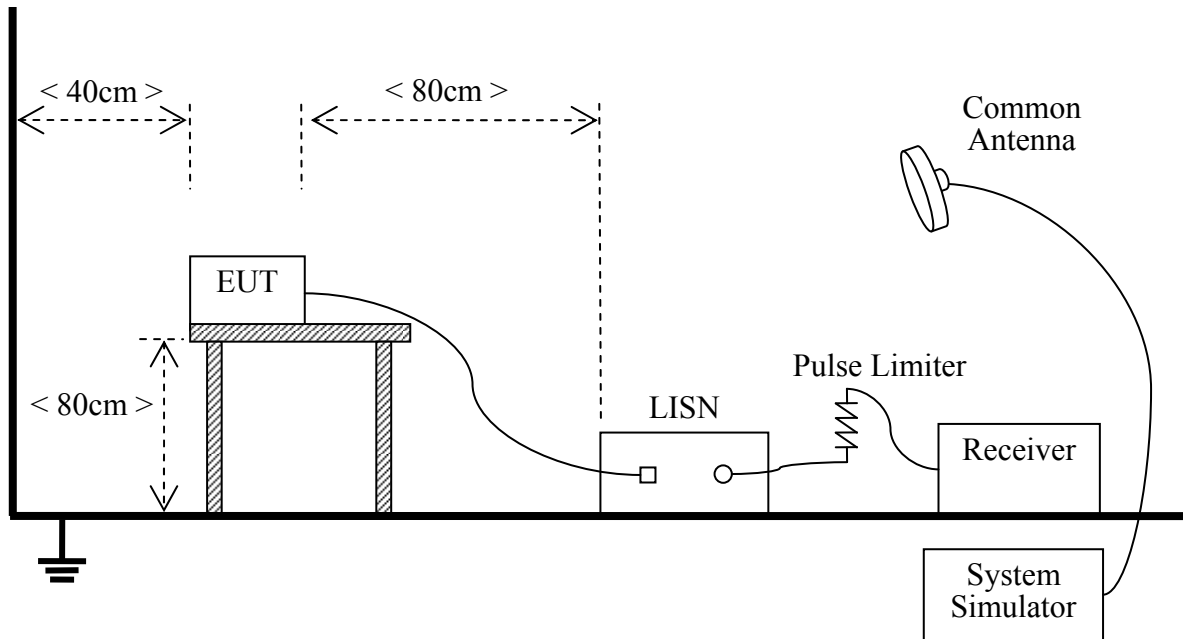
In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a special USB cable supplied by applicant. During the measurement, a communication link was established between the EUT and a System Simulator (SS), simultaneously, the data is transmitting between the PC and the TransFlash Card of the EUT.

NOTE: All test modes are performed, only the worst cases are recorded in this report.

## 2.2 Test Setup and Equipments List

### 2.2.1 Conducted Emission

#### A. Test Setup:



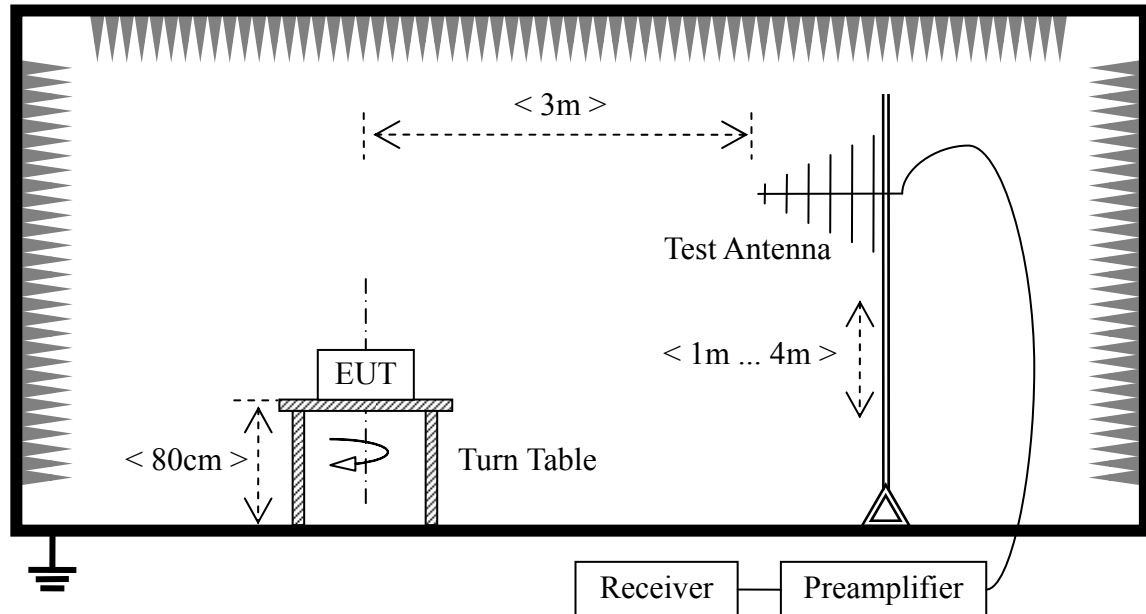
The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

#### B. Equipments List:

| Description          | Manufacturer | Model       | Serial No. | Cal. Date |
|----------------------|--------------|-------------|------------|-----------|
| Receiver             | Agilent      | E7405A      | US44210471 | 2011.05   |
| LISN                 | Schwarzbeck  | NSLK 8127   | 812744     | 2011.05   |
| Pulse Limiter (20dB) | Schwarzbeck  | VTSD 9561-D | 9391       | (n.a.)    |
| System Simulator     | Agilent      | E5515C      | GB43130131 | 2011.05   |
| Personal Computer    | IBM          | IBM_T20     | (n.a.)     | (n.a.)    |
| Bluetooth-Headset    | Nokia        | HS-36W      | (n.a.)     | (n.a.)    |
| T-Flash Card         | SanDisk      | 256MB       | (n.a.)     | (n.a.)    |

## 2.2.2 Radiated Emission

### C. Test Setup:



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

### D. Equipments List:

| Description           | Manufacturer | Model      | Serial No. | Cal. Date |
|-----------------------|--------------|------------|------------|-----------|
| Receiver              | Agilent      | E7405A     | US44210471 | 2011.05   |
| Semi-Anechoic Chamber | Albatross    | 9m*6m*6m   | (n.a.)     | 2011.05   |
| Test Antenna - Bi-Log | Schwarzbeck  | VULB 9163  | 9163-274   | 2011.05   |
| Test Antenna - Horn   | Schwarzbeck  | BBHA 9120C | 9120C-384  | 2011.05   |
| Personal Computer     | IBM          | IBM_T20    | (n.a.)     | (n.a.)    |
| Bluetooth-Headset     | Nokia        | HS-36W     | (n.a.)     | (n.a.)    |
| T-Flash Card          | SanDisk      | 256MB      | (n.a.)     | (n.a.)    |

### 3. 47 CFR PART 15B REQUIREMENTS

#### 3.1 Conducted Emission

##### 3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 $\mu$ H/50 $\Omega$  line impedance stabilization network (LISN).

| Frequency range (MHz) | Conducted Limit (dB $\mu$ V) |          |
|-----------------------|------------------------------|----------|
|                       | Quasi-peak                   | Average  |
| 0.15 - 0.50           | 66 to 56                     | 56 to 46 |
| 0.50 - 5              | 56                           | 46       |
| 5 - 30                | 60                           | 50       |

NOTE:

- The limit subjects to the Class B digital device.
- The lower limit shall apply at the band edges.
- The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

##### 3.1.2 Test Description

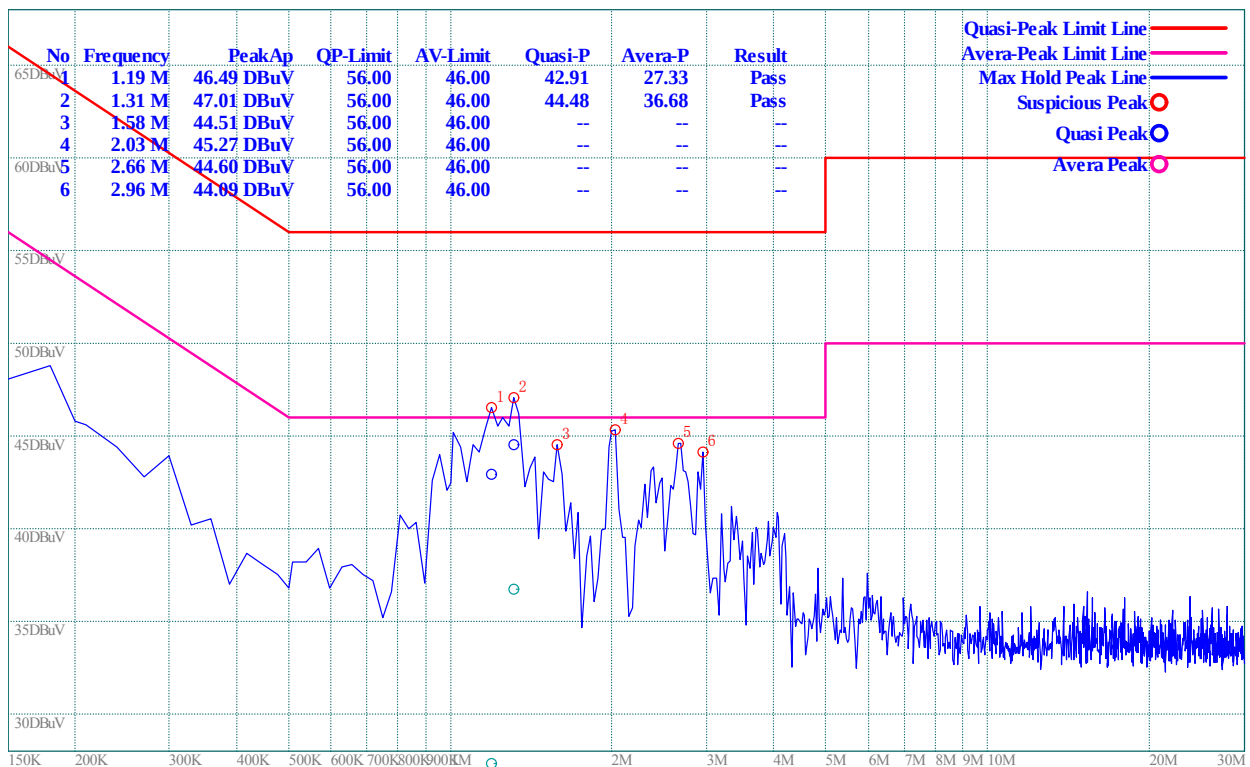
See section 2.2.1 of this report.

##### 3.1.3 Test Result

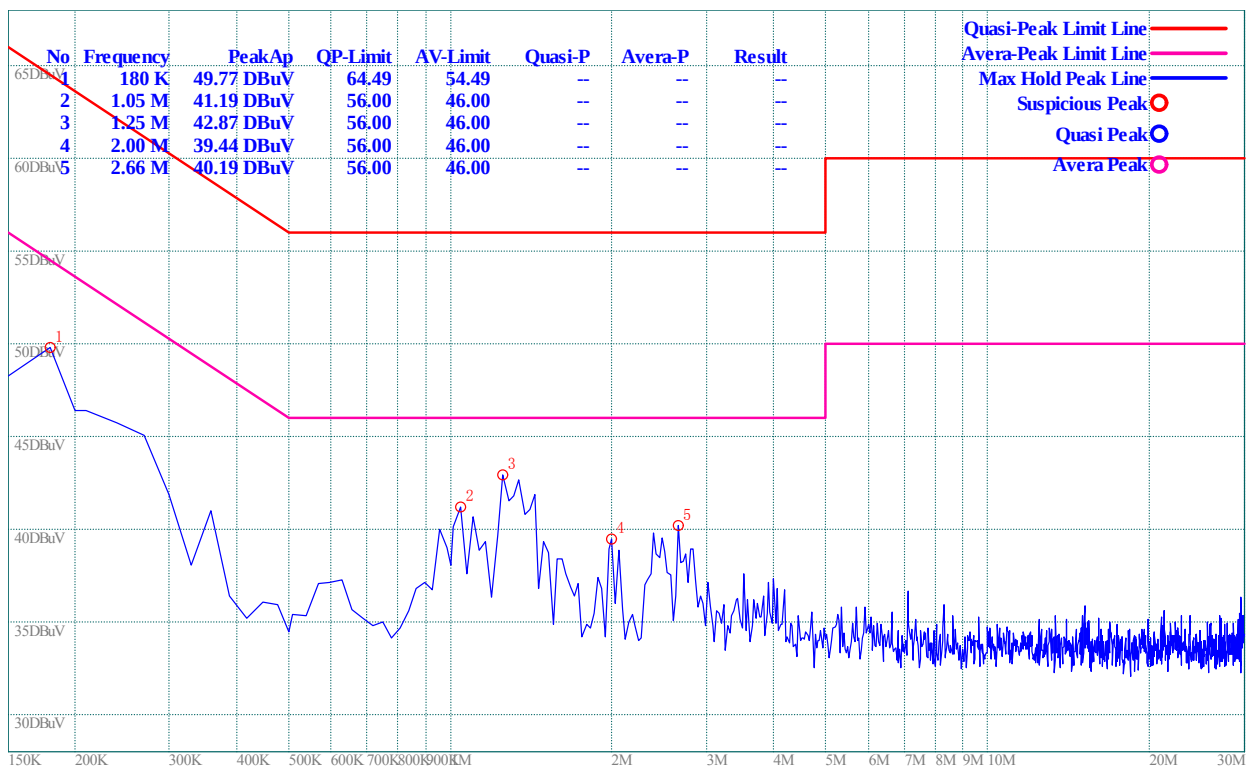
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

###### 3.1.3.1 Test Mode

###### A. Test Plot and Suspicious Points:



(Plot A: L Phase)



(Plot B: N Phase)

**Test Result :PASS**

## 3.2 Radiated Emission

### 3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

| Frequency range (MHz) | Field Strength  |                          |
|-----------------------|-----------------|--------------------------|
|                       | $\mu\text{V/m}$ | $\text{dB}\mu\text{V/m}$ |
| 30 - 88               | 100             | 40                       |
| 88 - 216              | 150             | 43.5                     |
| 216 - 960             | 200             | 46                       |
| Above 960             | 500             | 54                       |

NOTE:

- Field Strength ( $\text{dB}\mu\text{V/m}$ ) =  $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$ .
- In the emission tables above, the tighter limit applies at the band edges.

### 3.2.2 Test Description

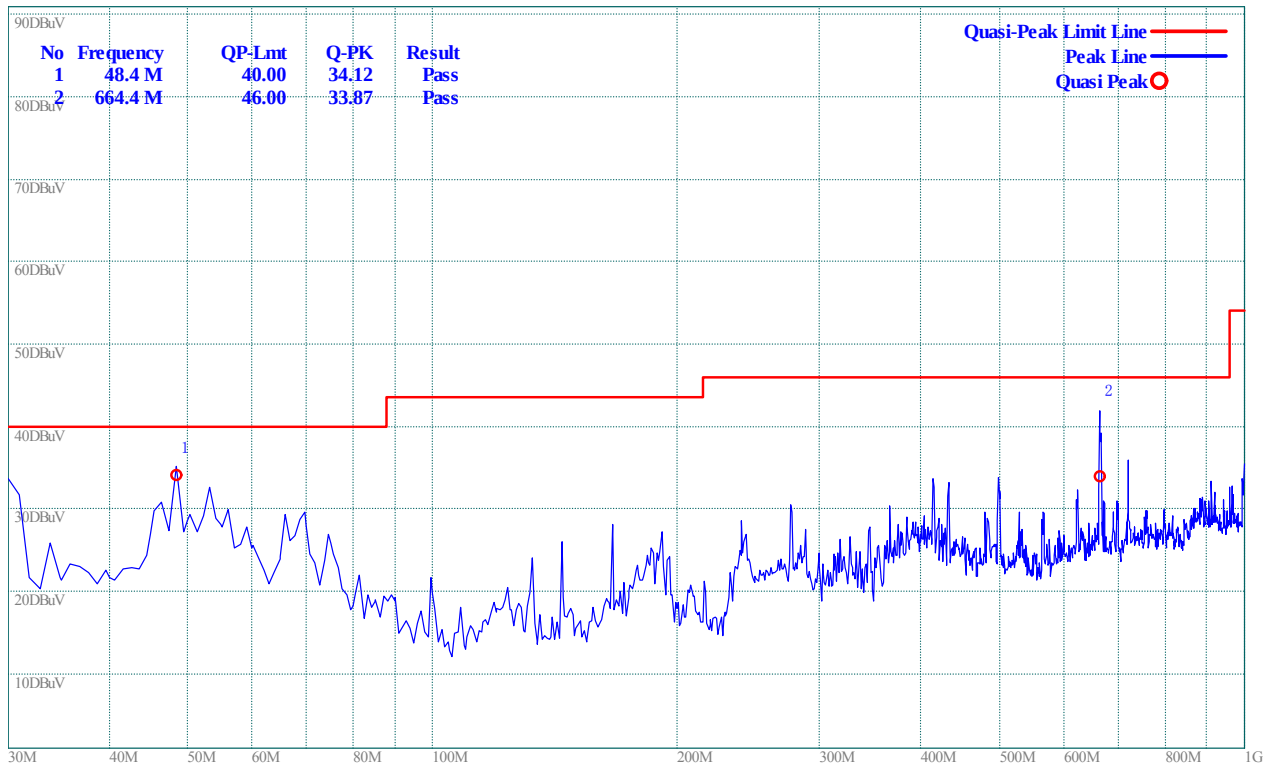
See section 2.2.2 of this report.

### 3.2.3 Test Result

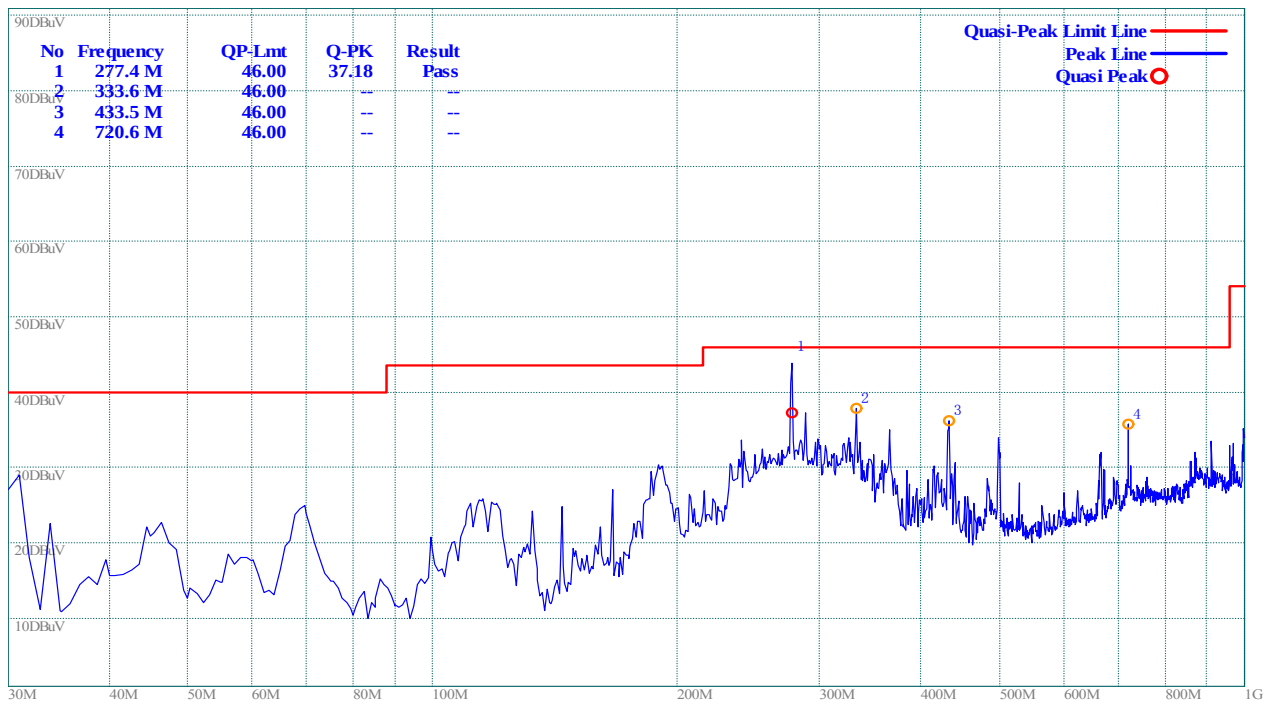
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

#### 3.2.3.1 Test Mode

##### A. Test Plots and Suspicious Points:



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

**Test Result :PASS**

**\*\* END OF REPORT \*\***